

**N-Channel MOSFET** 

### **General Description**

The WSF50N02 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSF50N02 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

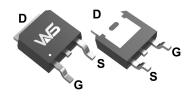
### **Product Summery**

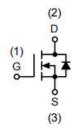
BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
20V	6.2mΩ	50A

## **Applications**

- Power Management for Industrial DC/DC Converters
- Ldeal for high-frequency switching and synchronous rectification

## **TO-252-2L Pin Configuration**





## **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
V <sub>DS</sub>	Drain-Source Voltage		20	\/
V <sub>GS</sub>	Gate-Source Voltage	±12	V	
. 7	Cantinuous Dunin Cumant	T <sub>C</sub> =25°C	50	
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =100°C	35	Α
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		120	
P <sub>D</sub> <sup>2</sup>	Power Dissipation	T <sub>C</sub> =25°C	42	W
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		25	Α
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy	L=0.5mH	150	mJ
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	°C
TJ	Operating Junction Temperature Range		-55 to 150	
D 14	T. 15 1 1	t≤10s	31	
R <sub>θJA</sub> <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	Steady State	62.5	°C/W
R <sub>eJC</sub>	Thermal Resistance-Junction to Case		3.6	

**N-Channel MOSFET** 

### Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	20			V
В	Otatia Busin Cassas On Basistana	$V_{GS}$ =4.5V , $I_D$ =20A		6.2	8.5	0
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}$ =2.5V , $I_D$ =15A		8.8	13	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=250\mu A$	0.4	0.7	1.1	V
	Duein Course Leekene Cument	V <sub>DS</sub> =20V , V <sub>GS</sub> =0V			1.0	
I <sub>DSS</sub>	Drain-Source Leakage Current	T <sub>J</sub> =55°C			5.0	μA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS}$ =0V , $V_{GS}$ =±10V			±100	nA
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =5V , $I_{D}$ =1A		18		S
$R_G$	Gate Resistance	f=1.0MHz		6.0		Ω
$Q_g$	Total Gate Charge (10V)			19		
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =10V , $V_{GS}$ =4.5V , $I_{D}$ =20A		3		nC
$Q_{gd}$	Gate-Drain Charge			6.6		
$T_{d(on)}$	Turn-On Delay Time			11		
T <sub>r</sub>	Rise Time	$V_{DD}$ =10V, $V_{GS}$ =4.5V, $I_{D}$ =10A		22		
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_L=1\Omega$ , $R_{GEN}=3\Omega$		39		ns
T <sub>f</sub>	Fall Time			20		
C <sub>iss</sub>	Input Capacitance			1500		
C <sub>oss</sub>	Output Capacitance	$V_{ m DS}$ =10V , $V_{ m GS}$ =0V , $f$ =1.0MHz		240		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			222		

#### **Diode Characteristics**

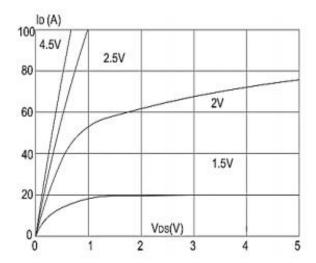
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				50	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	L =20A di/dt=100A/up		35		ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> =20A , di/dt=100A/μs		21		nC

#### Note:

- The value of R<sub>θJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited



## **Typical Characteristics**





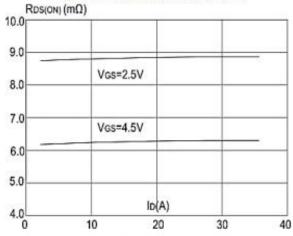


Figure 3:On-resistance vs. Drain Current

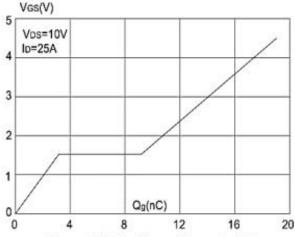


Figure 5: Gate Charge Characteristics

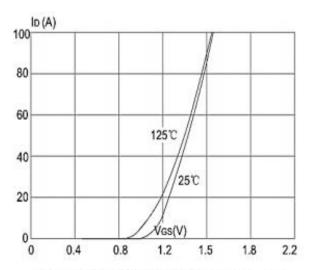


Figure 2: Typical Transfer Characteristics

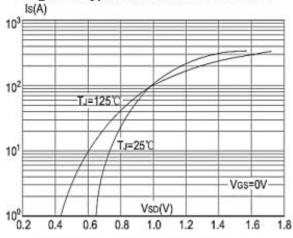


Figure 4: Body Diode Characteristics

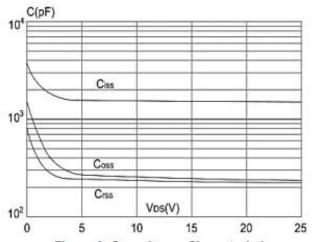


Figure 6: Capacitance Characteristics



## **Typical Characteristics**

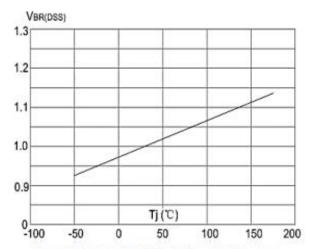


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

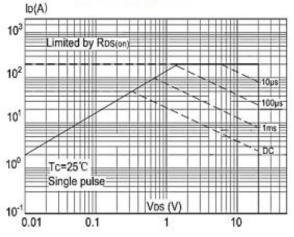


Figure 9: Maximum Safe Operating Area vs. Case Temperature

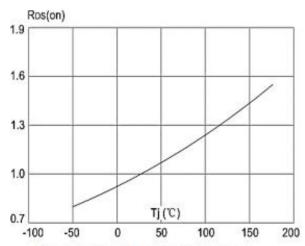


Figure 8: Normalized on Resistance vs Junction Temperature

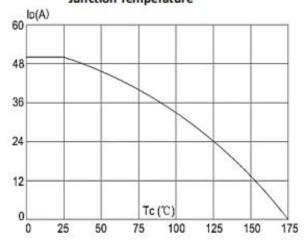


Figure 10: Maximum Continuous Drain Current

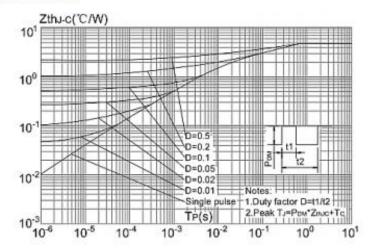
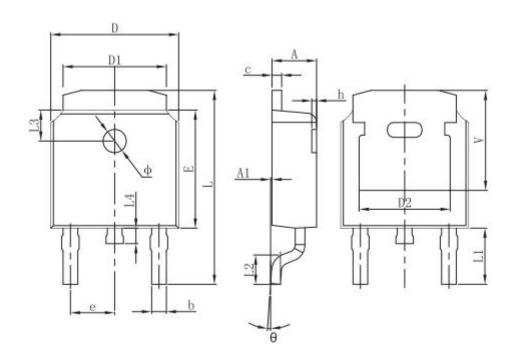


Figure.11: Maximum Effective
Transient Thermal Impedance, Junction-to-Case



# **Packaging information**



Combal	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830	REF.	0.190	REF.
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900	REF.	0.114	REF.
L2	1.400	1.700	0.055	0.067
L3	1.600	REF.	0.063	REF.
L4	0.600	1.000	0.024	0.039
Ф	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250	REF.	0.207	REF.





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